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DEPARTMENT OF COMMERCE

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INFORMATION DISCLOSURE CITATION



ATTY. DOCKET NO.  
148069/9235-37

SERIAL NO.  
09/783,795

APPLICANT:  
Francis J. Bensur

FILING DATE February  
15, 2001

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U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE (IF APPROPRIATE)
<i>FW</i>	AA	2,531,396	11/28/50	Carter, et al.	260	41.5	
	AB	2,886,550	05/12/59	Goren	260	33.6	
	AC	3,170,833	02/23/65	Noyes	161	186	
	AD	3,753,761	08/21/73	Sugahara et al.	117	36.2	
	AE	4,173,480	11/6/79	Woodward	430	536	
	AF	4,220,490	09/12/80	Carlson	156	257	
	AG	4,242,488	12/30/80	Stanley et al.	428	423.1	
	AH	4,352,858	10/5/82	Stanley	428	423.1	
	AI	4,374,939	02/22/83	Van Fisk, Jr. et al.	523	139	
	AJ	4,618,528	10/21/86	Sacks et al.	428	216	
	AK	4,653,640	03/13/87	Akao	206	455	
	AL	4,659,785	04/21/87	Nagano et al.	525	324	
	AM	4,725,466	02/16/88	Crass et al.	428	35	
	AN	4,739,007	01/19/88	Okada et al.	524	789	
	AO	4,786,558	11/26/88	Sumiya et al.	428	454	
	AP	4,803,035	02/17/89	Kresge et al.	264	519	
	AQ	4,868,152	09/15/89	Foulds et al.	503	212	
	AR	4,874,728	10/17/89	Eilliott et al.	501	148	
	AS	4,889,885	12/26/89	Usuki et al.	524	445	
<i>FW</i>	AT	4,906,517	03/04/90	Akao et al.	428	216	

FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES	NO

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER <i>S.M. Nelson</i>		DATE CONSIDERED <i>8-6-02</i>
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## U.S. PATENT DOCUMENTS

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EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE (IF APPROPRIATE)
SNW	BA 5,008,139	04/16/91	Ochi et al.	428	40	
	BB 5,041,330	08/26/91	Heerten et al.	428	213	
	BC 5,091,462	02/25/92	Fukui et al.	524	504	
	BD 5,102,948	04/21/92	Deguchi et al.	524	789	
	BE 5,190,997	03/21/93	Lindemann et al.	524	44	
	BF 5,221,568	06/21/93	Heerten et al.	428	213	
	BG 5,436,073	07/13/93	Williams et al.	428	343	
	BH 5,506,310	04/01/96	Vasselin et al.	525	426	
	BI 5,523,338	06/14/96	McCarthy et al.	523	466	
	BJ 5,527,616	06/18/96	Hatano et al.	428	423.1	
	BK 5,571,614	11/15/96	Harrison et al.	428	331	
	BL 5,580,630	12/13/96	Byrd	428	47	
	BM 5,585,129	12/14/96	Geddes et al.	426	394	
	BN 5,654,085	08/15/97	Markusch et al.	428	221	
	BO 5,662,983	09/24/97	Stark	428	117	
	BP 5,667,886	09/16/97	Gough et al.	428	331	
	BQ 5,670,226	09/24/97	Yoshizawa et al.	428	40.1	
	BR 5,747,560	05/15/98	Christiani et al.	523	209	
	BS 5,763,028	06/04/98	Matsumoto et al.	428	34.7	
SNW	BT 5,772,819	06/30/98	Olvey	156	82	

## FOREIGN PATENT DOCUMENTS

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		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO

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